<u>查询GT8G132_06供应商</u> TOSHIBA

GT8G132

TOSHIBA Insulated Gate Bipolar Transistor Silicon N Channel IGBT

GT8G132

Unit

Strobe Flash Applications

- Supplied in compact and thin package requires only a small mounting area
- 5th generation (trench gate structure) IGBT
- Enhancement-mode
- 4-V gate drive voltage: $V_{GE} = 4.0 \text{ V} \text{ (min)} \text{ (@IC} = 150 \text{ A)}$
- Peak collector current: IC = 150 A (max)

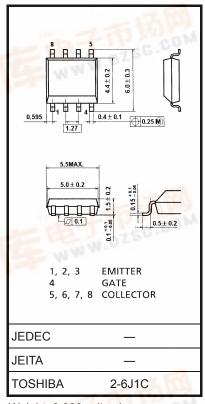
Abso	Absolute Maximum Ratings (Ta = 25°C)			
	Characteristics	Symbol	Rating	
Co	llector-emitter voltage	VCES	400	

Characteristics		Cymbol	rtating	Onic	
Collector-emitter voltage	V _{CES}	400	V		
Gate-emitter voltage	DC	V _{GES}	±6	V	
Oale-emiller voltage	Pulse	V _{GES}	±8		
Collector current	DC	Ic	8	А	
Collector current	1 ms	ICP	150	~	
Collector power dissipation (Note 1)		PC	1.1	W	
Junction temperature	Tj	150	°C		
Storage temperature range		T _{stg}	-55~150	°C	

Note 1: Drive operation: Mount on glass epoxy board [1 inch² \times 1.5 t]

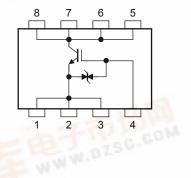
Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Weight: 0.080 g (typ.)

Equivalent Circuit



These devices are MOS type. Users should follow proper ESD handling procedures.

2006-11-02

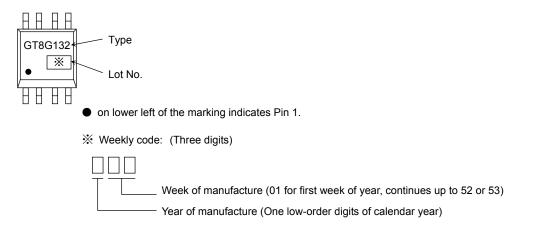
Unit: mm

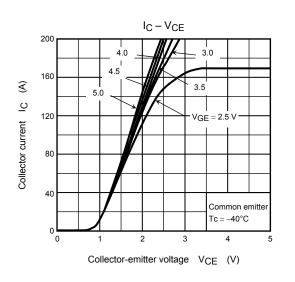
Electrical Characteristics	(Ta = 25°C)
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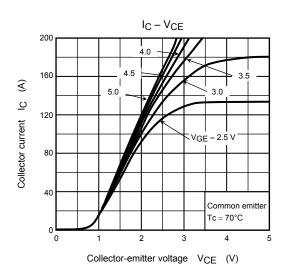
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		IGES	$V_{GE} = \pm 6 \text{ V}, V_{CE} = 0$	_		±10	μA
Collector cut-off current		ICES	$V_{CE} = 400 \text{ V}, \text{ V}_{GE} = 0$	_		10	μA
Gate-emitter cut-off voltage		V _{GE (OFF)}	$I_C = 1 \text{ mA}, V_{CE} = 5 \text{ V}$	0.6	_	1.2	V
Collector-emitter saturation voltage		V _{CE (sat)}	$I_{C} = 150 \text{ A}, \text{ V}_{GE} = 4 \text{ V}$		2.3	7.0	V
Input capacitance		Cies	$V_{CE}=10~V,~V_{GE}=0,~f=1~MHz$		2800	_	pF
Switching time	Rise time	tr	$\begin{array}{c} 4 \ V \\ 0 \\ \hline \\ V_{IN}: t_{r} \leq 100 \text{ ns} \\ t_{f} \leq 100 \text{ ns} \\ 300 \ V \end{array}$		1.0	_	- μs
	Turn-on time	t _{on}		_	1.1	—	
	Fall time	t _f			1.6	_	
	Turn-off time	t _{off}	Duty cycle ≦ 1%		2.2		
Thermal resistance (Note 2) R _{th (j-a)}		R _{th (j-a)}	_		_	114	°C/W

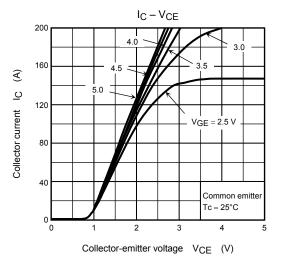
Note 2: Drive operation: Mount on glass epoxy board [1 inch² \times 1.5 t]

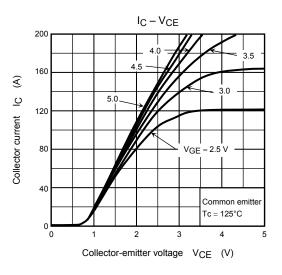
Marking

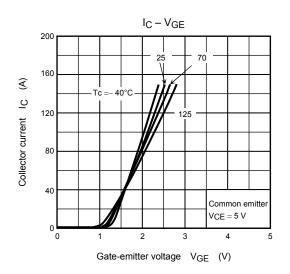


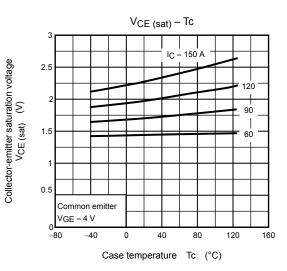


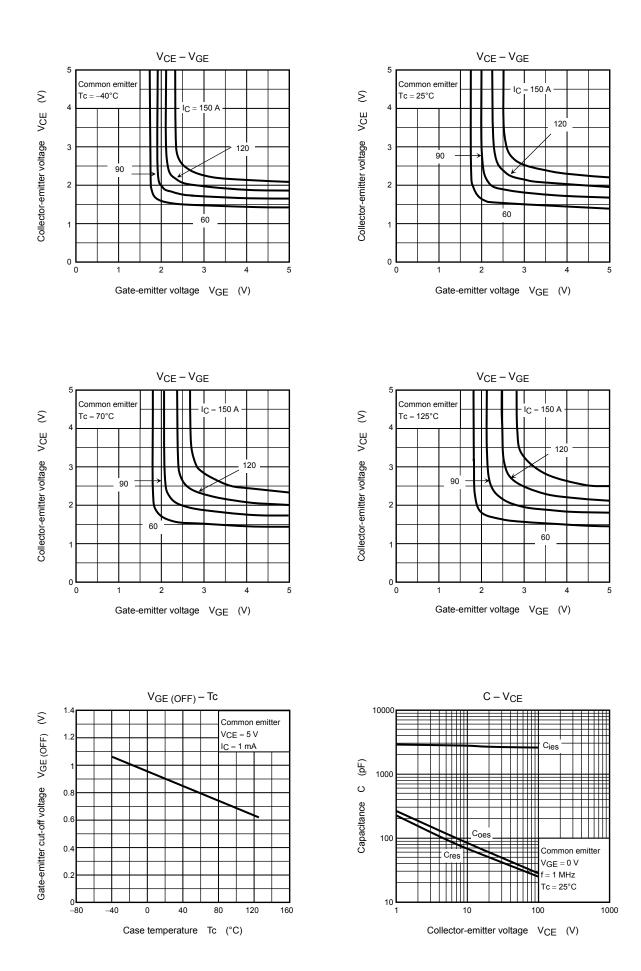




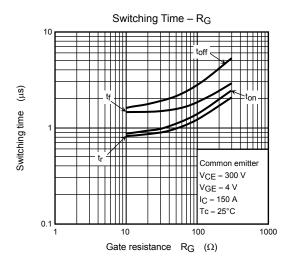


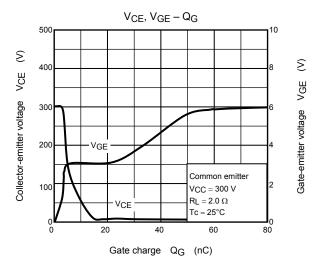


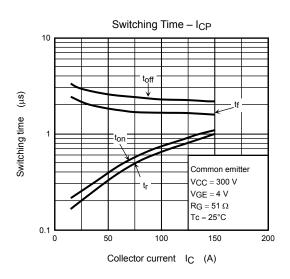


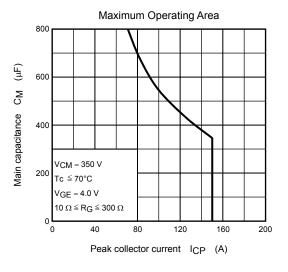


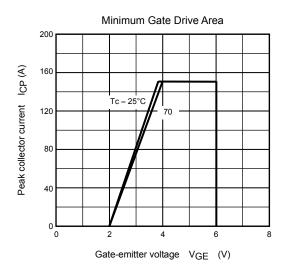
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RESTRICTIONS ON PRODUCT USE

Handbook" etc.

20070701-EN

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